

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/763,765	DIRSCH ET AL.		
Examiner	Art Unit		
 Rina I. Duda	2837		

	CEAD	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
318	727 139-434 610	5 24 05	Rel
	632		V
upd	ited	9/14/05	Ref
searc	h	'	
·			

INTERFERENCE SEARCHED							
Class	Subclass		ate		Examiner		
as	shown	of	14	K.	py		
in the)		7		,		
affact	ud						
cope	is						
	•						

(INCLUDING SEARCH STRATEGY)						
·	DATE	EXMR				
		•				
	·					
· · · · · · · · · · · · · · · · · · ·	· ·					
	·					